

规格书编号

SPEC NO :

# 产品规格书

# SPECIFICATION

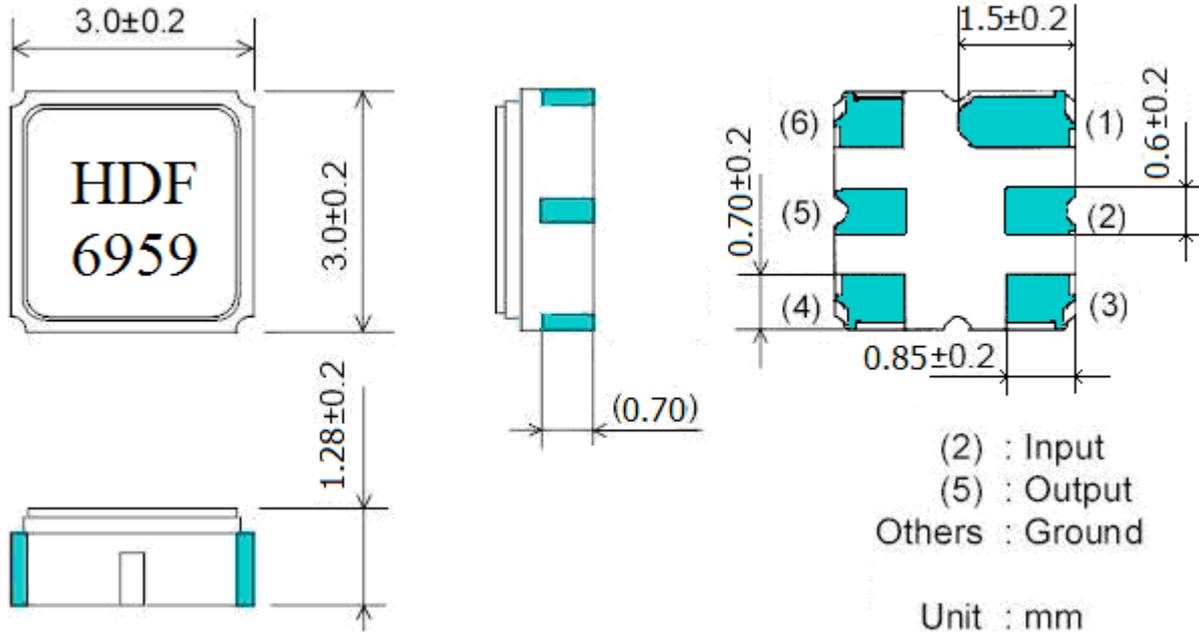
CUSTOMER 客户: \_\_\_\_\_  
PRODUCT 产品: \_\_\_\_\_ SAW FILTER \_\_\_\_\_  
MODEL NO 型号: \_\_\_\_\_ HDF930.5A-S6 \_\_\_\_\_  
MARKING 印字: \_\_\_\_\_ HDF6959 \_\_\_\_\_  
PREPARED 编制: \_\_\_\_\_ CHECKED 审核: \_\_\_\_\_  
APPROVED 批准: \_\_\_\_\_ D A T E 日期: \_\_\_\_\_ 2012-3-1 \_\_\_\_\_

客户确认 CUSTOMER RECEIVED:		
审核 CHECKED	批准 APPROVED	日期 DATE

无锡市好达电子有限公司  
Shoulder Electronics Limited



**1. Package Dimension**



**2. Marking: HDF6959**

- HD: Brand
- F: Filter
- 6: SMD-6
- 959: No.

**3. Performance**

**3.1 Application**

Low-Loss SAW Filter of cordless system.  
Center Frequency: 930.5 MHz

**3.2 Maximum Rating**

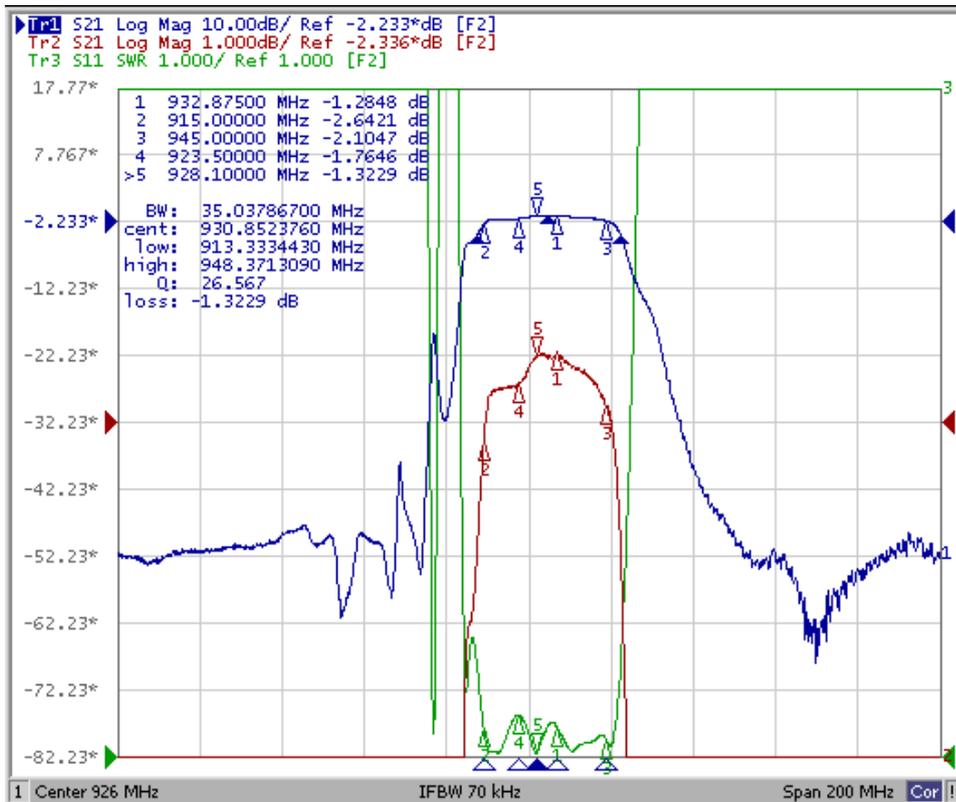
RF Power Level 10dBm

DC Voltage VDC	10V
AC Voltage Vpp	10V50Hz/60Hz
Operation temperature	-45°C to +85°C
Storage temperature	-45°C to +85°C

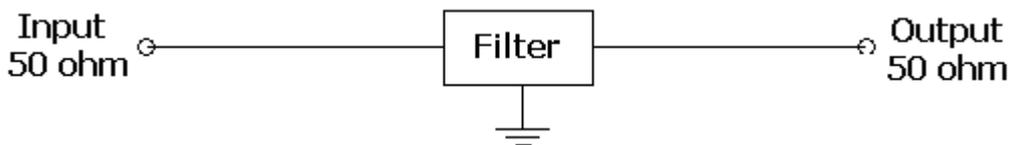
3.3 Electronic Characteristics

	Unit	Minimum	Typical	Maximum
Center Frequency	MHz	-	930.5	-
Insertion Loss (In Fc +/-12MHz)	dB		1.5	3.0
Amplitude Ripple (In Fc +/-12MHz)	dB		0.3	1.5
Relative Attenuation				
200MHz ~ 880 MHz	dB	40	50	-
990MHz ~ 1400MHz	dB	40	50	-
Input/Output Impedance	Ohms		50	

3.4 Frequency Characteristics



3.5 Test Circuit



**4. ENVIRONMENTAL CHARACTERISTICS**

4-1 High temperature exposure

Subject the device to +85°C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

4-2 Low temperature exposure

Subject the device to -40°C for 16 hours. Then release the device into the room conditions

for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

#### 4-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}\text{C}$  for 30 minutes. Following by a high temperature of  $+85^{\circ}\text{C}$  for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 3.3.

#### 4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}\text{C} \pm 10^{\circ}\text{C}$  for  $10 \pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 3.3.

#### 4-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}\text{C} \pm 5^{\circ}\text{C}$  for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 3.3.

#### 4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 3.3.

#### 4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 3.3.

## 5. REMARK

### 5.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

### 5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

### 5.3 Soldering

Only leads of component may be soldered . Please avoid soldering another part of component.